Amendment

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Group 222

Examiner R. A. Farley

Arent H. Kits Van Heyningen

Dual Channel Delay Sensing Circuit(U

Serial No. 944,530 /

Filed September 11, 1978

RAYTHEON COMPANY EXECUTIVE OFFICES 141 SPRING STREET

LEXINGTON, MA 02173

RECEIVED

Hon. Commissioner of Patents and Trademarks

Washington, D.C. 20231

Sir:

AMENDMENT

(y) In response to the Office Action dated October 30, 1979, please amend herein as follows:

In the Claims

(Amended) A delay measurement circuit comprising: 1. first and second channels for receiving first and second signals, each of said signals having a leading edge and a trailing edge;

a leading edge circuit coupled to said first and said second channels for signaling the temporal relationship of the leading edges of said first and said second signals;

a trailing edge circuit coupled to said first and said . second channels for signaling the temporal relationship of the trailing edges of said first and said second signals;

a memory coupled to said leading edge circuit for storing data of said leading edges;

timing means activated by said leading edge circuit for measuring a delay between leading edges of said first and said second signals; [and]

> DECLASSIFY ON Decist 2008 REVIEW ON

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